

Application/Control No. 10/606,464

10/000,40

Examiner
Devona E. Faulk

Applicant(s)/Patent under Reexamination

LU ET AL.

8

Art Unit 2615

ORIGINAL						INTERNATIONAL CLASSIFICATION									
CLASS 381			SUBCLASS 104				CL	AIMED	-	NON-CLAIMED					
					Н	3	G	3	/00			1			
CROSS REFERENCES				Н	3	G	7	/00							
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)														
381	104	106	56		Н	4	R	29	/00			1			
700	94				G	6	F	17	/00			1			
340	392.3				G	8	В	3	/00			/			
								•	1			1			
									1			1			
Devona E. Faulk 6/14/2007 (Assistant Examiner) (Date)						CHIN		NER	Total Claims Allowed: 36						
TECHNOL					OGY CENTER 2300 Examiner) (Date)					O.G. Print F					

Claims renu	enumbered in the same order as presented by applicant						☐ CPA			☐ T.D.		☐ R.1.47	
Final	Final	Final	Final	Original		Final	Original		Final	Original		Final	Original
4-1	31	29 61		91			121			151			181
- 2	32	30 62		92			122			152_			182
- 3	33_	3/ 63		93			123			153			183
4	34	32 64		94			124			154			184
5	35	3 65		95			125			155			185
6	36	3 4 66		96			126			156_			186
7-	- 37	32 67		97			127			157		<u> </u>	187
/ 8	38	3 68		98			128			158			188
2 9	39→	69		99			129			159			189
3 10	-40	70		100			130			160			190
4 11	41-	71		101	j		131			161			191
5 12	42	72		102			132			162			192
13	43	73		103			133			163			193
7 14	12 44	74		104			134			164			194
- 15	1 3 45	75		105			135			165			195
% 16	74 46	76		106			136			166			196
9 17	7.5 47	77		107			137			167			197
10 18	1 0 48	78		108			138			168			198
7 / 19	17, 49	79		109			139			169			199
20_	18 50	80		110			140			170			200
-21	J 9 51	81		111			141			171			201
- 22	20 52	82		112			142			172			202
- 23	2 53	83		113			143			173			203
24	QQ 54	84		114			144			174			204
25-	23 55	85		115			145			175			205
28>	2 × 56	86		116			146			176			206
27-	25 57	87		117			147			177			207
28	4 58	88		118			148			178			208
29	27, 59	89		119			149			179			209
30_	24 60	90		120			150	<u> </u>		180			210

(Legal Instruments Examiner)

(Date)